MRF9030M Rev. 9, 5/2006

Technical Data

Replaced by MRF9030NR1/NBR1. There are no form, fit or function changes with this part replacement. N suffix added to part number to indicate transition to lead-free terminations.

RF Power Field Effect Transistors

N-Channel Enhancement-Mode Lateral MOSFETs

Designed for broadband commercial and industrial applications with frequencies up to 1000 MHz. The high gain and broadband performance of these devices make them ideal for large-signal, common-source amplifier applications in 26 volt base station equipment.

• Typical Performance at 945 MHz, 26 Volts

Output Power — 30 Watts PEP Power Gain — 20 dB Efficiency — 41% (Two Tones) IMD - -31 dBc

- Integrated ESD Protection
- Capable of Handling 5:1 VSWR, @ 26 Vdc, 945 MHz, 30 Watts CW **Output Power**
- **Excellent Thermal Stability**
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Dual-Lead Boltdown Plastic Package Can Also Be Used As Surface Mount.
- 200°C Capable Plastic Package
- TO-272-2 in Tape and Reel. R1 Suffix = 500 Units per 44 mm, 13 inch Reel.
- TO-270-2 in Tape and Reel. R1 Suffix = 500 Units per 24 mm, 13 inch Reel.

MRF9030MR1 **MRF9030MBR1**

945 MHz, 30 W, 26 V LATERAL N-CHANNEL **BROADBAND RF POWER MOSFETs**

CASE 1265-08, STYLE 1 TO-270-2 **PLASTIC**

CASE 1337-03, STYLE TO-272-2 **PLASTIC** MRF9030MBR1



Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	- 0.5, +65	Vdc
Gate-Source Voltage	V_{GS}	- 0.5, +15	Vdc
Total Device Dissipation @ T _C = 25°C Derate above 25°C	P _D	139 0.93	W W/°C
Storage Temperature Range	T _{stg}	- 65 to +150	°C
Operating Junction Temperature	TJ	200	°C

Table 2. Thermal Characteristics

Characteristic 5		Value	Unit
Thermal Resistance, Junction to Case		1.08	°C/W

Table 3. ESD Protection Characteristics

Test Conditions		Class
Human Body Model		1 (Minimum)
Machine Model		M2 (Minimum)
Charge Device Model	MRF9030MR1 MRF9030MBR1	C7 (Minimum) C6 (Minimum)

Table 4. Moisture Sensitivity Level

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD 22-A113, IPC/JEDEC J-STD-020	3	260	°C

NOTE - CAUTION - MOS devices are susceptible to damage from electrostatic charge. Reasonable precautions in handling and packaging MOS devices should be observed.

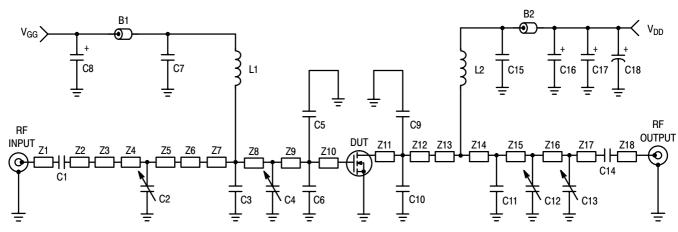


Table 5. Electrical Characteristics (T _c = 25°c Unless Othen Characteristic	Symbol	Min	Тур	Max	Unit
Off Characteristics					I
Zero Gate Voltage Drain Leakage Current (V _{DS} = 65 Vdc, V _{GS} = 0 Vdc)	I _{DSS}	_	_	10	μAdc
Zero Gate Voltage Drain Leakage Current (V _{DS} = 26 Vdc, V _{GS} = 0 Vdc)	I _{DSS}	_	_	1	μAdc
Gate-Source Leakage Current (V _{GS} = 5 Vdc, V _{DS} = 0 Vdc)	I _{GSS}	_	_	1	μAdc
On Characteristics					
Gate Threshold Voltage ($V_{DS} = 10 \text{ Vdc}, I_D = 100 \mu \text{Adc}$)	V _{GS(th)}	2	2.9	4	Vdc
Gate Quiescent Voltage (V _{DS} = 26 Vdc, I _D = 250 mAdc)	V _{GS(Q)}	3	3.8	5	Vdc
Drain-Source On-Voltage (V _{GS} = 10 Vdc, I _D = 0.7 Adc)	V _{DS(on)}	_	0.23	0.4	Vdc
Forward Transconductance (V _{DS} = 10 Vdc, I _D = 2 Adc)	9 _{fs}	_	2.7	_	S
Dynamic Characteristics					
Input Capacitance (V_{DS} = 26 Vdc \pm 30 mV(rms)ac @ 1 MHz, V_{GS} = 0 Vdc)	C _{iss}	_	49	_	pF
Output Capacitance $(V_{DS} = 26 \text{ Vdc} \pm 30 \text{ mV(rms)ac} @ 1 \text{ MHz}, V_{GS} = 0 \text{ Vdc})$	C _{oss}	_	27	_	pF
Reverse Transfer Capacitance ($V_{DS} = 26 \text{ Vdc} \pm 30 \text{ mV(rms)}$ ac @ 1 MHz, $V_{GS} = 0 \text{ Vdc}$)	C _{rss}	_	1.2	_	pF
unctional Tests (In Freescale Test Fixture)					
Two-Tone Common-Source Amplifier Power Gain $(V_{DD}=26\ Vdc,\ P_{out}=30\ W\ PEP,\ I_{DQ}=250\ mA,\ f1=945.0\ MHz,\ f2=945.1\ MHz)$	G _{ps}	18	20	_	dB
Two-Tone Drain Efficiency $(V_{DD}=26~Vdc,~P_{out}=30~W~PEP,~I_{DQ}=250~mA, f1=945.0~MHz,~f2=945.1~MHz)$	η	37	41	_	%
3rd Order Intermodulation Distortion $(V_{DD}=26\ Vdc,\ P_{out}=30\ W\ PEP,\ I_{DQ}=250\ mA, f1=945.0\ MHz, f2=945.1\ MHz)$	IMD	_	-31	-28	dBc
Input Return Loss $(V_{DD} = 26 \text{ Vdc}, P_{out} = 30 \text{ W PEP}, I_{DQ} = 250 \text{ mA}, \\ f1 = 945.0 \text{ MHz}, f2 = 945.1 \text{ MHz})$	IRL	_	-13	-9	dB
Two-Tone Common-Source Amplifier Power Gain $(V_{DD}=26~Vdc,~P_{out}=30~W~PEP,~I_{DQ}=250~mA,~f1=930.0~MHz,~f2=930.1~MHz~and~f1=960.0~MHz,~f2=960.1~MHz)$	G _{ps}	_	20	_	dB
Two-Tone Drain Efficiency $(V_{DD}=26~Vdc,~P_{out}=30~W~PEP,~I_{DQ}=250~mA, f1=930.0~MHz,~f2=930.1~MHz~and~f1=960.0~MHz, f2=960.1~MHz)$	η	_	40.5		%
3rd Order Intermodulation Distortion $(V_{DD}=26~Vdc,~P_{out}=30~W~PEP,~I_{DQ}=250~mA, f1=930.0~MHz, f2=930.1~MHz and f1=960.0~MHz, f2=960.1~MHz)$	IMD	_	-31	_	dBc
Input Return Loss (V _{DD} = 26 Vdc, P _{out} = 30 W PEP, I _{DQ} = 250 mA, f1 = 930.0 MHz, f2 = 930.1 MHz and f1 = 960.0 MHz, f2 = 960.1 MHz)	IRL	_	-12	-	dB

MRF9030MR1 MRF9030MBR1



ARCHIVE INFORMATION



Z1	0.260" x 0.060" Microstrip	Z11	0.360" x 0.270" Microstrip
Z2	0.240" x 0.060" Microstrip	Z12	0.050" x 0.270" Microstrip
Z3	0.500" x 0.100" Microstrip	Z13	0.110" x 0.060" Microstrip
Z4	0.200" x 0.270" Microstrip	Z14	0.220" x 0.060" Microstrip
Z 5	0.330" x 0.270" Microstrip	Z15	0.100" x 0.060" Microstrip
Z6	0.140" x 0.270" x 0.520", Taper	Z16	0.870" x 0.060" Microstrip
Z 7	0.040" x 0.520" Microstrip	Z17	0.240" x 0.060" Microstrip
Z8	0.090" x 0.520" Microstrip	Z18	0.340" x 0.060" Microstrip
Z9	0.370" x 0.520" Microstrip (MRF9030MR1)	Board	Taconic RF-35-0300, $\varepsilon_r = 3.5$
	0.290" x 0.520" Microstrip (MRF9030MBR1)		
Z10	0.130" x 0.520" Microstrip (MRF9030MR1)		

Figure 1. 930-960 MHz Broadband Test Circuit Schematic

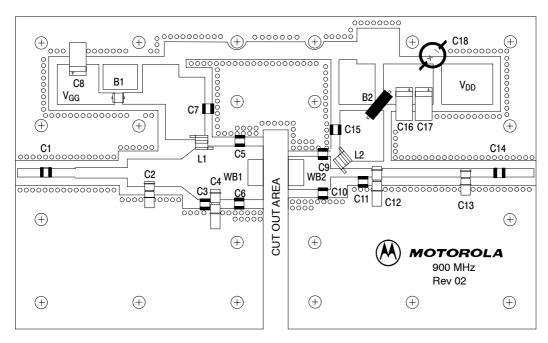
Table 6. 930 - 960 MHz Broadband Test Circuit Component Designations and Values

0.210" x 0.520" Microstrip (MRF9030MBR1)

Part	Description	Part Number	Manufacturer	
B1	Short Ferrite Bead, Surface Mount	95F786	Newark	
B2	Long Ferrite Bead, Surface Mount	95F787	Newark	
C1, C7, C14, C15	47 pF Chip Capacitors	100B470JP 500X	ATC	
C2	0.6-4.5 Variable Capacitor, Gigatrim	44F3360	Newark	
C3, C11	3.9 pF Chip Capacitors	100B3R6BP 500X	ATC	
C4, C12	0.8-8.0 Variable Capacitors, Gigatrim 44F3360		Newark	
C5, C6	6.8 pF Chip Capacitors	100B7R5JP 500X	ATC	
C8, C16, C17	10 μF, 35 V Tantulum Chip Capacitors	93F2975	Newark	
C9, C10	10 pF Chip Capacitors	100B100JP 500X	ATC	
C13	1.8 pF Chip Capacitor (MRF9030MR1) 0.6-4.5 Variable Capacitor, Gigatrim (MRF9030MBR1)	100B1R8BP 44F3360	ATC Newark	
C18	220 μF Electrolytic Chip Capacitor	14F185	Newark	
L1, L2	12.5 nH Coilcraft Inductors	A04T-5	Coilcraft	
WB1, WB2	20 mil Brass Shim (0.250 x 0.250)	RF-Design Lab	RF-Design Lab	
PCB	Etched Circuit Board	900 MHz μ250/Viper Rev 02	DSelectronics	

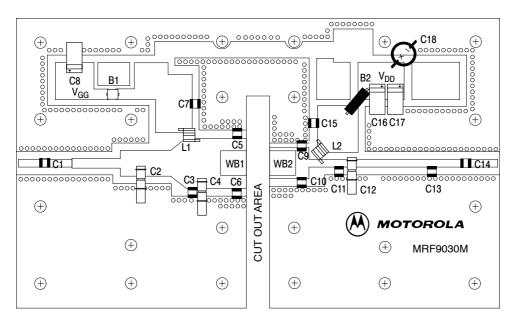


ARCHIVE INFORMATION



Freescale has begun the transition of marking Printed Circuit Boards (PCBs) with the Freescale Semiconductor signature/logo. PCBs may have either Motorola or Freescale markings during the transition period. These changes will have no impact on form, fit or function of the current product.

Figure 2. 930-960 MHz Broadband Test Circuit Component Layout (MRF9030MR1)



Freescale has begun the transition of marking Printed Circuit Boards (PCBs) with the Freescale Semiconductor signature/logo. PCBs may have either Motorola or Freescale markings during the transition period. These changes will have no impact on form, fit or function of the current product.

Figure 3. 930-960 MHz Broadband Test Circuit Component Layout (MRF9030MBR1)



TYPICAL CHARACTERISTICS

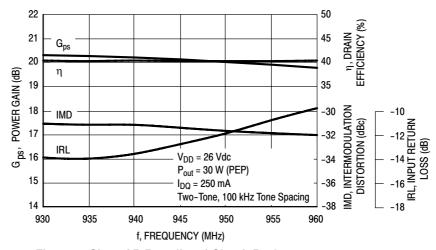


Figure 4. Class AB Broadband Circuit Performance

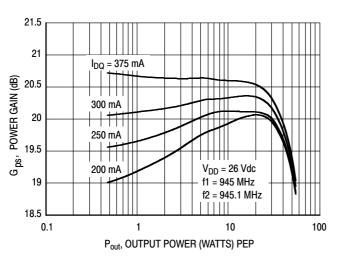


Figure 5. Power Gain versus Output Power

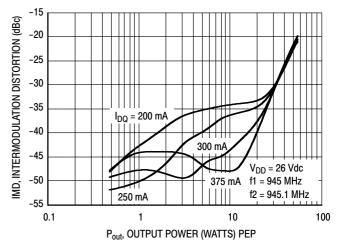


Figure 6. Intermodulation Distortion versus
Output Power

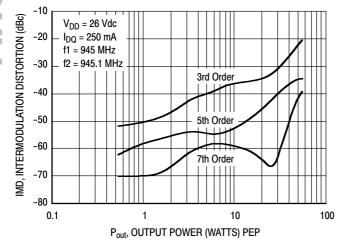


Figure 7. Intermodulation Distortion Products versus Output Power

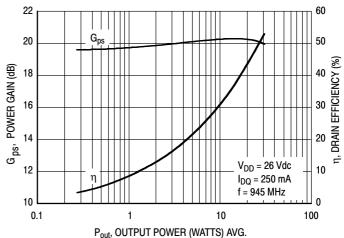


Figure 8. Power Gain and Efficiency versus
Output Power

MRF9030MR1 MRF9030MBR1



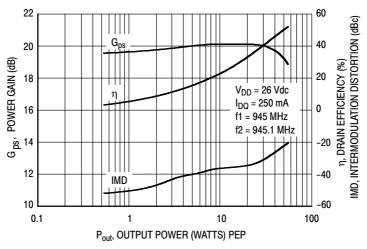
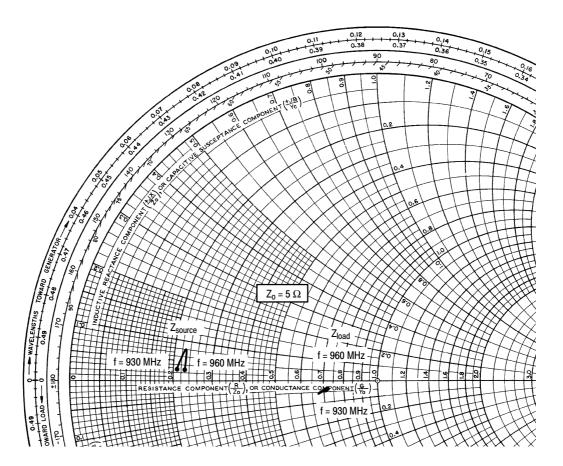


Figure 9. Power Gain, Efficiency and IMD versus Output Power



ARCHIVE INFORMATION



 V_{DD} = 26 V, I_{DQ} = 250 mA, P_{out} = 30 Watts (PEP)

f MHz	$\mathbf{Z_{source}}_{\Omega}$	$oldsymbol{Z_{load}}{\Omega}$
930	1.07 + j0.160	3.53 - j0.20
945	1.14 + j0.385	3.41 - j0.24
960	1.17 + j0.170	3.60 - j0.17

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

Note: Z_{load} was chosen based on tradeoffs between gain, output power, drain efficiency and intermodulation distortion.

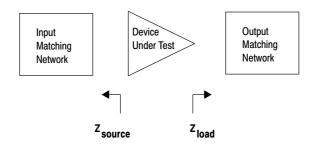
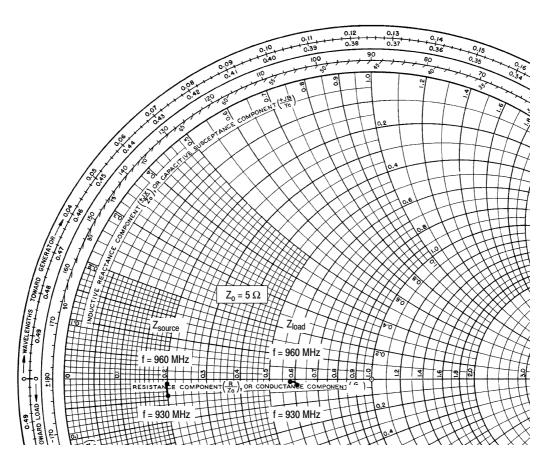


Figure 10. Series Equivalent Source and Load Impedance (MRF9030MR1)

MRF9030MR1 MRF9030MBR1





 V_{DD} = 26 V, I_{DQ} = 250 mA, P_{out} = 30 Watts (PEP)

f MHz	$\mathbf{Z_{source}}_{\Omega}$	$oldsymbol{Z_{load}}{\Omega}$
930	1.0 - j0.18	3.05 - j0.09
945	1.0 - j0.10	3.00 - j0.07
960	1.0 - j0.03	2.95 - j0.03

Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

Note: Z_{load} was chosen based on tradeoffs between gain, output power, drain efficiency and intermodulation distortion.

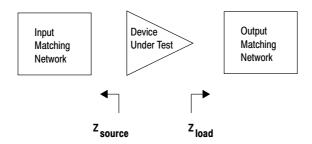


Figure 11. Series Equivalent Source and Load Impedance (MRF9030MBR1)



NOTES



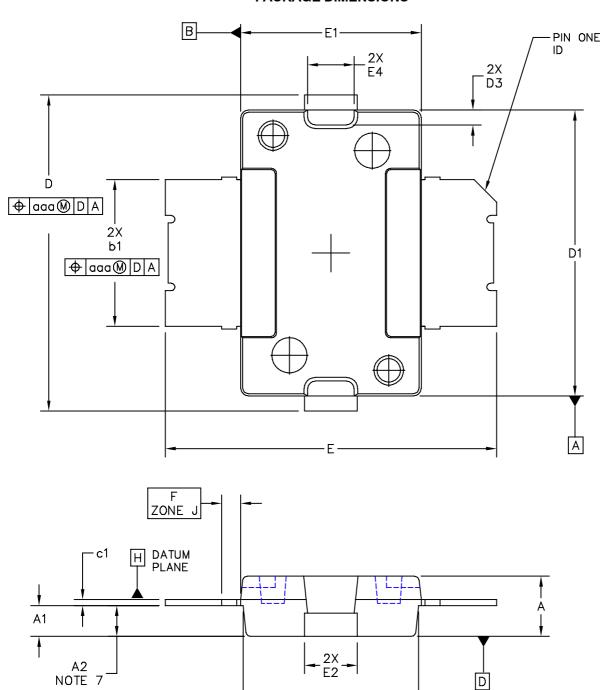
NOTES



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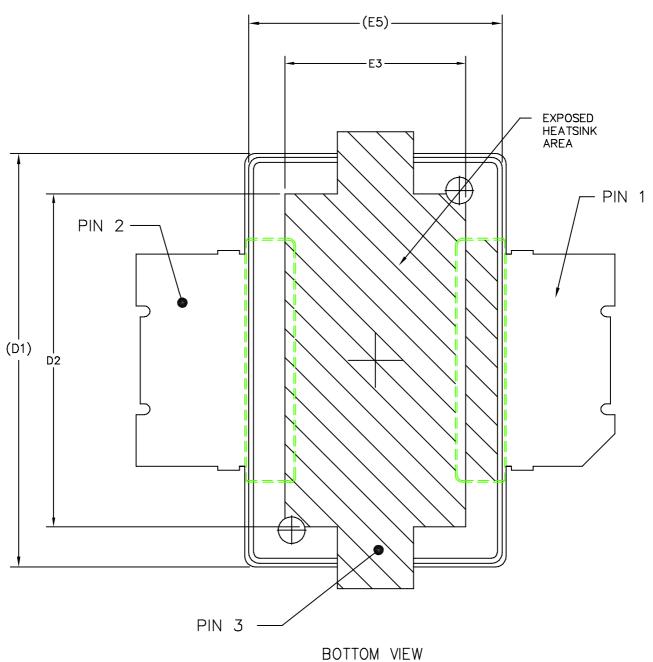
PACKAGE DIMENSIONS



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SOIN ACE MOON	I	STANDARD: NO	N-JEDEC	

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TO-270 SURFACE MOUN	Γ	CASE NUMBER	R: 1265–08	01 APR 2005
SON ACE WOON	I	STANDARD: NO	N-JEDEC	



NOTES:

- 1. CONTROLLING DIMENSION: INCH
- 2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
- 3. DATUM PLANE -H- IS LOCATED AT TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
- 4. DIMENSIONS "D1" AND "E1" DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 PER SIDE. DIMENSIONS "D1 AND "E1" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -H-.
- 5. DIMENSION "b1" DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 TOTAL IN EXCESS OF THE "b1" DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 6. DATUMS -A- AND -B- TO BE DETERMINED AT DATUM PLANE -H-.
- 7. DIMENSION "A2" APPLIES WITHIN ZONE "J" ONLY.
- 8. DIMENSIONS "D" AND "E2" DO NOT INCLUDE MOLD PROTRUSION. OVERALL LENGTH INCLUDING MOLD PROTRUSION SHOULD NOT EXCEED 0.430 INCH FOR DIMENSION "D" AND 0.080 INCH FOR DIMENSION "E2". DIMENSIONS "D" AND "E2" DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -D-.

STYLE 1:

PIN 1 - DRAIN

PIN 2 - GATE PIN 3 - SOURCE

	IN	INCH MILLIMETER INCH		INCH	MILLIN	/ETER			
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
Α	.078	.082	1.98	2.08	2.08 F .025 BSC		25 BSC	0.64	BSC
A1	.039	.043	0.99	1.09	b1	.193	.199	4.90	5.06
A2	.040	.042	1.02	1.07	c1	.007	.011	0.18	0.28
D	.416	.424	10.57	10.77	aaa		.004	0.	10
D1	.378	.382	9.60	9.70					
D2	.290	.320	7.37	8.13					
D3	.016	.024	0.41	0.61					
E	.436	.444	11.07	11.28					
E1	.238	.242	6.04	6.15					
E2	.066	.074	1.68	1.88					
E3	.150	.180	3.81	4.57					
E4	.058	.066	1.47	1.68					
E5	.231	.235	5.87	5.97					
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TITLE:

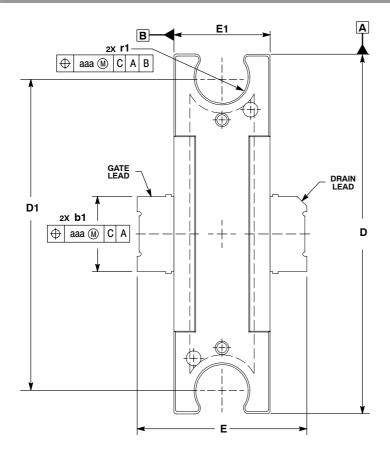
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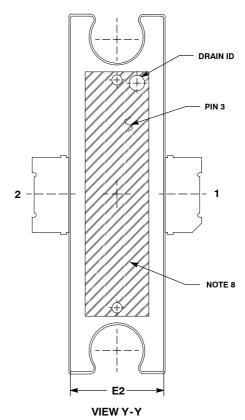
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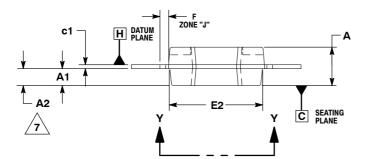
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 DATUM PLANE -H-.
 7. DIMENSION A2 APPLIES WITHIN ZONE "J" ONLY.
 8. CROSSHATCHING REPRESENTS THE EXPOSED
 AREA OF THE HEAT SLUG.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	.100	.104	2.54	2.64
A1	.039	.043	0.99	1.09
A2	.040	.042	1.02	1.07
D	.928	.932	23.57	23.67
D1	.810 BSC		20.57 BSC	
Е	.438	.442	11.12	11.23
E1	.248	.252	6.30	6.40
E2	.241	.245	6.12	6.22
F	.025 BSC		0.64 BSC	
b1	.193	.199	4.90	5.05
c1	.007	.011	.18	.28
r1	.063	.068	1.60	1.73
222	004		10	

STYLE 1: PIN 1. DRAIN 2. GATE 3. SOURCE

CASE 1337-03 ISSUE C TO-272-2 **PLASTIC MRF9030MBR1**



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